IN THE CLAIMS:

Please amend the claims as follows:

1-12. (canceled)

- 13. (currently amended) A mobile phone comprising:
 - a system for analysing connection conditions between an integrated circuit package <u>within said mobile phone</u> and a circuit board <u>within said mobile phone</u>, said system comprising:
 - coupling elements coupling said integrated circuit package electrically to said circuit board, and
 - support elements directly connecting said integrated circuit package mechanically with said circuit board using solder balls,
 - conductors configured to electrically connect at least two of said support elements with each other on the side of the integrated circuit package,
 - measuring means a measurement device arranged at said support elements and configured to pick-off physical values between said support elements, and
 - evaluation means a determination device configured to evaluate said physical
 values to determine mechanical properties of said support elements, and
 configured to conclude a condition of said electrical coupling of said integrated
 circuit package with said circuit board from said determined mechanical
 properties of said support elements.
- 14. (previously presented) The mobile phone of claim 13, wherein said support elements are arranged between said circuit board and said integrated circuit package.

- 15. (previously presented) The mobile phone of claim 13, wherein said support elements are solder pads.
- 16. *(previously presented)* The mobile phone of claim 13, wherein said support elements are arranged adjacent to said coupling elements.
- 17. *(previously presented)* The mobile phone of claim 13, wherein said support elements are arranged semicircular along said coupling elements.
- 18. (previously presented) The mobile phone of claim 13, wherein said support elements are arranged along edges and/or at corners of said integrated circuit package.
- 19. (previously presented) The mobile phone of claim 13, wherein said integrated circuit package is a chip scale package or a chip size package.
- 20. *(currently amended)* The mobile phone claim 13, wherein said measuring means provide measurement device provides picking-off electrical conditions of said support elements.
- 21. *(currently amended)* The mobile phone claim 13, wherein said measuring means provide measurement device provides picking-off mechanical conditions of said support elements.
- 22. *(currently amended)* The mobile phone of claim 13, wherein <u>a</u> storage means are comprised to store stores said picked-off physical values.
- 23. (currently amended) The mobile phone of claim 13, wherein said evaluation

means compare determination device compares said picked-off physical values with comparative values to determine connection condition.

- 24. *(currently amended)* The mobile phone of claim 13, wherein said evaluation means provide determination device provides an error message in case a poor connection condition is determined.
- 25. *(currently amended)* The mobile phone of claim 13, wherein said error message is stored within said storage [[means]].
- 26. (previously presented) The mobile phone of claim 13, wherein an interface is provided to read out said stored physical values and/or stored error messages.

27-29. (canceled)

- 30. (currently amended) An apparatus comprising:
 - coupling elements coupling an integrated circuit package electrically to a circuit board,
 - support elements directly connecting said integrated circuit package mechanically with said circuit board using solder balls,
 - conductors configured to electrically connect at least two of said support elements with each other on the side of the integrated circuit package,
 - measuring means a measurement device arranged at said support elements and configured to pick-off physical values between said support elements, and
 - evaluation means a determination device configured to evaluate said physical values to determine mechanical properties of said support elements, and configured to conclude a condition of said electrical coupling of said integrated

circuit package with said circuit board from said determined mechanical properties of said support elements.

- 31. *(previously presented)* The system of claim 30, wherein said support elements are arranged semicircular along said coupling elements.
- 32. *(previously presented)* The apparatus of claim 30, wherein said support elements are arranged along edges and/or at corners of said integrated circuit package.
- 33. (previously presented) An apparatus comprising:
 - coupling elements coupling an integrated circuit package electrically to a circuit board, and
 - support elements directly connecting said integrated circuit package mechanically with said circuit board using solder balls,
 - means for electrically connecting at least two of said support elements with each other on the side of the integrated circuit package,
 - measuring means arranged at said support elements for picking off physical values between said support elements, and
 - evaluation means for evaluating said physical values to determine mechanical properties of said support elements, and for concluding a condition of said electrical coupling of said integrated circuit package with said circuit board from said determined mechanical properties of said support elements.
- 34. *(previously presented)* The apparatus of claim 33, wherein said support elements are arranged semicircular along said coupling elements.